# 54F573,74F573

54F573 74F573 Octal D-Type Latch with TRI-STATE(RM) Outputs



Literature Number: SNOS207A



## 54F/74F573

## Octal D-Type Latch with TRI-STATE® Outputs

#### **General Description**

# The 'F573 is a high speed octal latch with buffered common Latch Enable (LE) and buffered common Output Enable $(\overline{OE})$ inputs.

This device is functionally identical to the 'F373 but has different pinouts.

#### **Features**

- Inputs and outputs on opposite sides of package allowing easy interface with microprocessors
- Useful as input or output port for microprocessors
- Functionally identical to 'F373
- TRI-STATE outputs for bus interfacing
- Guaranteed 4000V minimum ESD protection

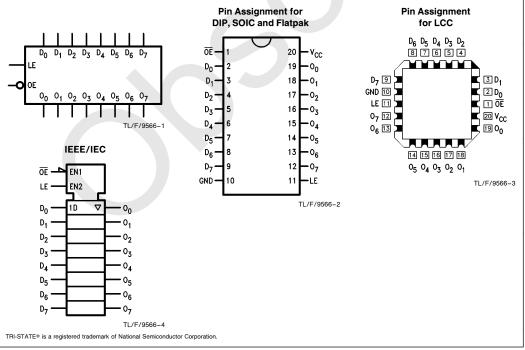
Commercial	Military	Package Number	Package Description
74F573PC		N20A	20-Lead (0.300" Wide) Molded Dual-In-Line
	54F573DM (Note 2)	J20A	20-Lead Ceramic Dual-In-Line
74F573SC (Note 1)		M20B	20-Lead (0.300" Wide) Molded Small Outline, JEDEC
74F573SJ (Note 1)		M20D	20-Lead (0.300" Wide) Molded Small Outline, EIAJ
	54F573FM (Note 2)	W20A	20-Lead Cerpak
	54F573LM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C

Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

### **Logic Symbols**

### **Connection Diagrams**



## **Unit Loading/Fan Out**

		54F/74F			
Pin Names	Description	U.L. HIGH/LOW	Input I <sub>IH</sub> /I <sub>IL</sub> Output I <sub>OH</sub> /I <sub>OL</sub>		
D <sub>0</sub> -D <sub>7</sub>	Data Inputs	1.0/1.0	20 μA/-0.6 mA		
LE	Latch Enable Input (Active HIGH)	1.0/1.0	20 μA/ – 0.6 mA		
ŌĒ	TRI-STATE Output Enable Input (Active LOW)	1.0/1.0	20 μA/ – 0.6 mA		
O <sub>0</sub> -O <sub>7</sub>	TRI-STATE Latch Outputs	150/40(33.3)	-3 mA/24 mA (20 mA)		

### **Functional Description**

The 'F573 contains eight D-type latches with 3-state output buffers. When the Latch Enable (LE) input is HIGH, data on the D<sub>n</sub> inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change state each time its D input changes. When LE is LOW the latches store the information that was present on the D inputs a setup time preceding the HIGH-to-LOW transition of LE. The 3state buffers are controlled by the Output Enable (OE) input. When  $\overline{OE}$  is LOW, the buffers are in the bi-state mode. When  $\overline{\text{OE}}$  is HIGH the buffers are in the high impedance mode but this does not interfer with entering new data into the latches.

#### **Function Table**

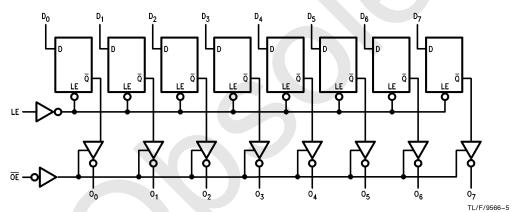
	Outputs		
ŌĒ	LE	D	0
L	Н	Н	Н
L	Н	L	L
L	L	X	00
Н	X	X	Z

H = HIGH Voltage Level

L = LOW Voltage Level
X = Immaterial

O<sub>0</sub> = Value stored from previous clock cycle

### **Logic Diagram**



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

#### **Absolute Maximum Ratings** (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

 $\begin{array}{lll} \text{Storage Temperature} & -65^{\circ}\text{C to} + 150^{\circ}\text{C} \\ \text{Ambient Temperature under Bias} & -55^{\circ}\text{C to} + 125^{\circ}\text{C} \\ \text{Junction Temperature under Bias} & -55^{\circ}\text{C to} + 175^{\circ}\text{C} \\ \text{Plastic} & -55^{\circ}\text{C to} + 150^{\circ}\text{C} \\ \end{array}$ 

V<sub>CC</sub> Pin Potential to

Ground Pin -0.5V to +7.0V Input Voltage (Note 2) -0.5V to +7.0V Input Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output in HIGH State (with  $V_{CC} = 0V$ )

 $\begin{array}{lll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{TRI-STATE Output} & -0.5 \text{V to } +5.5 \text{V} \end{array}$ 

Current Applied to Output in LOW State (Max) twice the rated I<sub>OL</sub> (mA) ESD Last Passing Voltage (Min) 4000V

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

# Recommended Operating Conditions

Free Air Ambient Temperature

Supply Voltage

Military + 4.5V to + 5.5V Commercial + 4.5V to + 5.5V

#### **DC Electrical Characteristics**

Symbol	Parameter		54F/74F			Units	V <sub>CC</sub>	Conditions	
Syllibol	raiame	iei	Min Typ Max		Omis	VCC	Conditions		
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V <sub>CD</sub>	Input Clamp Diode Vo	ltage			-1.2	V	Min	$I_{IN} = -18 \text{ mA}$	
V <sub>OH</sub>	Output HIGH Voltage	54F 10% V <sub>CC</sub> 54F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub> 74F 5% V <sub>CC</sub> 74F 5% V <sub>CC</sub>	2.5 2.4 2.5 2.4 2.7 2.7			V	Min	$\begin{split} I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \\ I_{OH} &= -1 \text{ mA} \\ I_{OH} &= -3 \text{ mA} \end{split}$	
V <sub>OL</sub>	Output LOW Voltage	54F 10% V <sub>CC</sub> 74F 10% V <sub>CC</sub>			0.5 0.5	V	Min	$I_{OL} = 20 \text{ mA}$ $I_{OL} = 24 \text{ mA}$	
I <sub>IH</sub>	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Max	V <sub>IN</sub> = 2.7V	
I <sub>BVI</sub>	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	$V_{IN} = 7.0V$	
I <sub>CEX</sub>	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Max	V <sub>OUT</sub> = V <sub>CC</sub>	
V <sub>ID</sub>	Input Leakage Test	74F	4.75			V	0.0	$I_{\text{ID}} = 1.9  \mu\text{A}$ All Other Pins Grounded	
I <sub>OD</sub>	Output Leakage Circuit Current				3.75	μΑ	0.0	V <sub>IOD</sub> = 150 mV All Other Pins Grounded	
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$	
l <sub>OZH</sub>	Output Leakage Current				50	μΑ	Max	V <sub>OUT</sub> = 2.7V	
l <sub>OZL</sub>	Output Leakage Curre	ent			-50	μΑ	Max	V <sub>OUT</sub> = 0.5V	
los	Output Short-Circuit Current		-60		<b>-150</b>	mA	Max	V <sub>OUT</sub> = 0V	
I <sub>ZZ</sub>	Bus Drainage Test				500	μΑ	0.0V	V <sub>OUT</sub> = 5.25V	
I <sub>CCL</sub>	Power Supply Current			35	55	mA	Max	$V_O = LOW$	
lccz	Power Supply Current		35	55	mA	Max	V <sub>O</sub> = HIGH Z		

## **AC Electrical Characteristics**

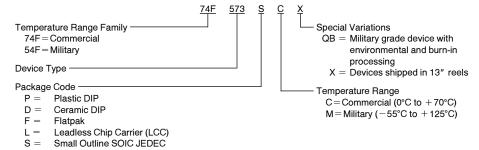
Symbol	Parameter	$74F$ $T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		V	$\begin{array}{c} 54 \text{F} \\ \\ \text{T}_{\text{A}}, \text{V}_{\text{CC}} = \text{Mil} \\ \\ \text{C}_{\text{L}} = 50 \text{ pF} \end{array}$		74F  T <sub>A</sub> , V <sub>CC</sub> = Com C <sub>L</sub> = 50 pF		Units
		Min	Тур	Max	Min	Max	Min	Max	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay D <sub>n</sub> to O <sub>n</sub>	3.0 2.0	5.3 3.7	7.0 6.0	3.0 2.0	9.0 7.0	3.0 2.0	8.0 6.5	ns
t <sub>PLH</sub>	Propagation Delay LE to O <sub>n</sub>	5.0 3.0	9.0 5.2	11.0 7.0	5.0 3.0	13.5 7.5	5.0 3.0	12.0 7.0	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output Enable Time	2.0 2.0	5.0 5.6	8.0 8.5	2.0 2.0	10.0 10.0	2.0 2.0	9.0 9.5	ns
t <sub>PHZ</sub>	Output Disable Time	1.5 1.5	4.5 3.8	5.5 5.5	1.5 1.5	7.0 5.5	1.5 1.5	6.5 5.5	115

# **AC Operating Requirements**

ΨLZ		.5	3.0	 1.5	5.5	1.5	0.0	
AC Op	perating Requireme	ents						
			74F	54 <b>F</b>		74	F	
Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		T <sub>A</sub> , V <sub>CC</sub> = Mil		T <sub>A</sub> , V <sub>CC</sub> = Com		Units
		Min	Max	Min	Max	Min	Max	
t <sub>S</sub> (H) t <sub>S</sub> (L)	Setup Time, HIGH or LOW D <sub>n</sub> to LE	2.0 2.0		2.0 2.0		2.0 2.0		ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold Time, HIGH or LOW D <sub>n</sub> to LE	3.0 3.5		3.0 4.0		3.0 3.5		113
t <sub>w</sub> (H)	LE Pulse Width, HIGH	4.0		4.0		4.0		ns

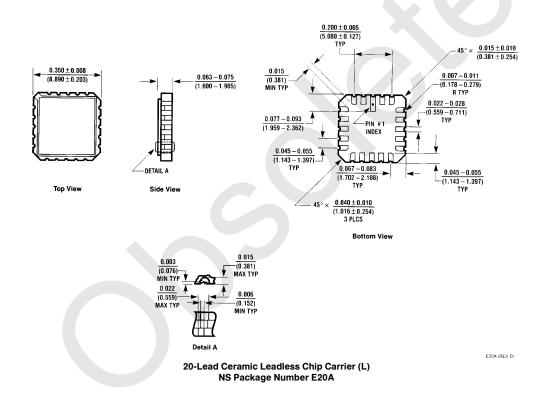


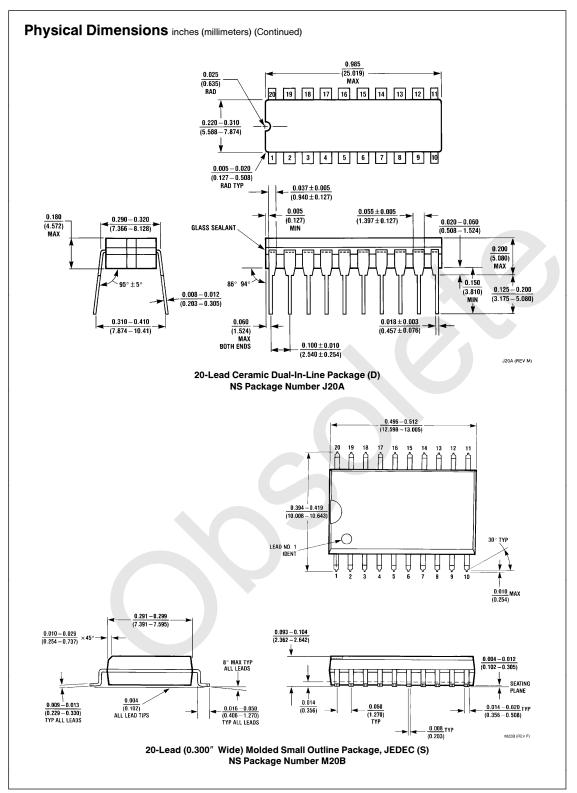
The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:

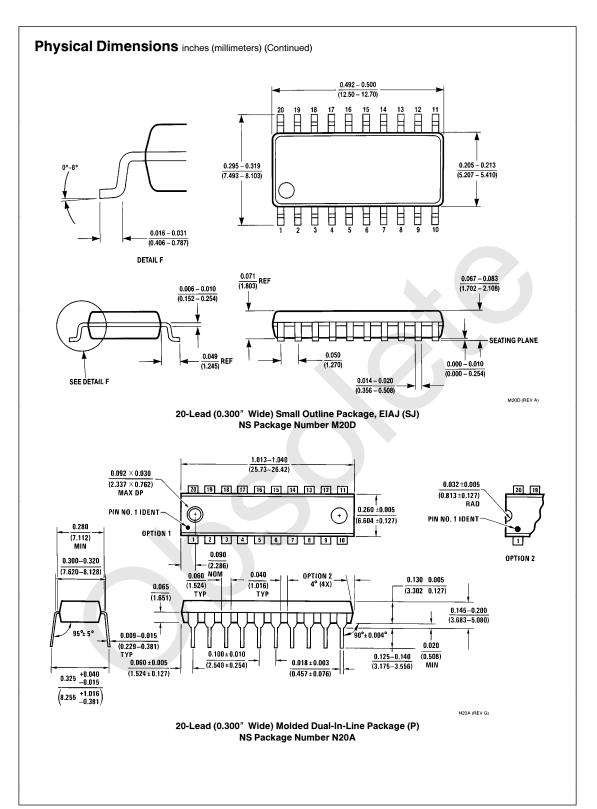


# Physical Dimensions inches (millimeters)

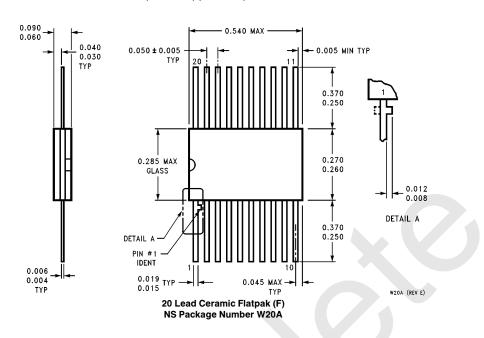
SJ = Small Outline SOIC EIAJ







## Physical Dimensions inches (millimeters) (Continued)



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